

INTERNATIONAL STANDARD

NORME INTERNATIONALE

Method of measurement of current noise generated in fixed resistors

Méthode pour la mesure du bruit produit en charge par les résistances fixes





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INTERNATIONAL
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CONTENTS

FOREWORD.....	4
1 Scope.....	6
2 Normative references.....	6
3 Terms and definitions	6
4 Method of measurement	7
4.1 Noise basics	7
4.1.1 Noise	7
4.1.2 Thermal noise	8
4.1.3 Current noise	8
4.2 Measurement principle	9
4.3 Measurement system	10
4.3.1 Proposal of a suitable measuring system	10
4.3.2 Alternative measuring systems	11
4.4 Measurement system requirements	11
4.4.1 Input circuit.....	11
4.4.2 Isolation resistor R_M	12
4.4.3 DC voltage source	12
4.4.4 DC electronic voltmeter	12
4.4.5 Calibration resistor R_{Cal}	12
4.4.6 Calibration source	13
4.4.7 Determination of the calibration voltage	13
4.4.8 AC band-pass amplifier	15
4.4.9 AC r.m.s. meter.....	16
4.4.10 Test fixture	16
4.5 Verification of the measuring system	17
4.5.1 Performance check by measurement of instrument and thermal noise	17
4.5.2 Performance check by comparison of repeated measurements.....	17
5 Measurement procedure	18
5.1 Ambient conditions	18
5.2 Preparation of specimen.....	18
5.3 Procedure	18
5.3.1 General	18
5.3.2 Calibration	18
5.3.3 Measurement of system noise S	18
5.3.4 Measurement of total noise T	19
5.4 Precautions.....	22
6 Evaluation of measurement results.....	22
6.1 Term for the contribution of system noise	22
6.2 Determination of the current-noise index A_1	24
6.3 Determination of the current-noise voltage ratio CNR_U	25
6.4 Accuracy.....	26
6.5 Requirements.....	26
7 Information to be given in the relevant component specification	26
Annex A (informative) Letter symbols and abbreviations	27
A.1 Letter symbols	27

A.2 Abbreviations	27
Annex X (informative) Cross-reference for references to the prior revision of this standard	28
Bibliography	29
Figure 1 – Block schematic of a suitable measuring system	11
Figure 2 – Typical transfer function of the band-pass amplifier	16
Figure 3 – Contribution of system noise, $f(T - S)$	23
Table 1 – Permissible limits of system noise	17
Table 2 – Recommended operating conditions (1 of 2)	20
Table 3 – Numeric values of the contribution of system noise, $f(T - S)$	24
Table X.1 – Cross reference for references to the 1 st edition of this standard	28

INTERNATIONAL ELECTROTECHNICAL COMMISSION

**METHOD OF MEASUREMENT OF CURRENT
NOISE GENERATED IN FIXED RESISTORS**

FOREWORD

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International Standard IEC 60195 has been prepared by IEC technical committee 40: Capacitors and resistors for electronic equipment.

This second edition cancels and replaces the first edition published in 1965 and constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- harmonization of the allocation of isolation resistors R_M in the recommended operating conditions given in Table 2;
- correction of erroneous numeric values of the contribution of system noise, $f(T - S)$ in Table 3;
- addition of advice on the prescription of requirements in a relevant component specification;
- addition of a set of recommended measuring conditions for specimens with a rated dissipation of less than 100 mW;

- complete editorial revision.

The text of this standard is based on the following documents:

FDIS	Report on voting
40/2431/FDIS	40/2458/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

METHOD OF MEASUREMENT OF CURRENT NOISE GENERATED IN FIXED RESISTORS

1 Scope

This International Standard specifies a method of measurement and associated test conditions to assess the "noisiness", or magnitude of current noise, generated in fixed resistors of any given type. The method applies to all classes of fixed resistors. The aim is to provide comparable results for the determination of the suitability of resistors for use in electronic circuits having critical noise requirements.

The current noise in resistive materials reflects the granular structure of the resistive material. For some resistor technologies utilizing homogenous layers it is regarded as providing an indication of defects, which are considered as a root cause for abnormal ageing of the component under the influence of temperature and time.

The method described in this International Standard is not a general specification requirement and therefore is applied if prescribed by a relevant component specification, or, if agreed between a customer and a manufacturer.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60068-1:2013, *Environmental testing – Part 1: General and guidance*

3 Terms and definitions

For the purposes of this document the following terms and definitions apply.

3.1

current-noise

combination of all random fluctuations of current flow in a resistor which are not attributed to thermal agitation of the charge carriers (thermal noise) and which depend on the applied direct current

3.2

current-noise index

logarithmic index of the ratio of the open circuit r.m.s. current-noise voltage in a frequency decade, in μV , over the d.c. voltage applied under test, in V, used to express the "noisiness" of an individual resistor

Note 1 to entry: The current-noise index is expressed in dB. The ratio between μV and V is not considered in this index, leading to its value being 120 dB less than the mathematical current-noise index A_1' . This practical index follows the history of prior revisions of this method.